Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/684,770	LI ET AL.	
Examiner	**Art Unit**	
Hiep T. Nguyen	2187	

SEARCHED			
Class	Subclass	Date	Examiner
711	170	Text search only	
	171		
	172		
	173	2/1/06	HN
717	140		
	156		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search hist. is attached	2/1/06	HN
NPL search using terms similar to EAST search		
Inventorship search.		